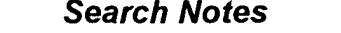


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	09/490,748	BENDETT ET AL.
	<b>Examiner</b>	Art Unit
	Dung (Michael) T. Nguyen	2828

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
372	22	3/2/2005	DN

A diagram consisting of two horizontal black lines. The top line is a single horizontal segment with two vertical tick marks on its left side. The bottom line is a single horizontal segment with two vertical tick marks on its right side.